Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/825,507	LEE, EDWARD HIN PONG
Examiner	Art Unit
Paul D. Kim	3729

	SEARCHED				
Class	Subclass	Date	Examiner		
29	603.07 603.13- 603.16 603.18	2/6/2006	PK		
205	199 122				
306	121 122 123				
	126 317	/			
451	5,41	V			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
PgPub Text Search See attachment		2/6/2006	РК		

SEARCH NO (INCLUDING SEARCH		·)
	DATE	EXMR
Reviewed US APPLICATION 10/825,508 (Pending)	2/6/2006	PK
Reviewed Parent Application 10/156,333 (US PAT. 6,848,166)	2/6/2006	PK
Updated Text Search EAST/NPL (IEEE)	2/6/2006	PK
PgPub Text Search EAST	2/6/2006	PK